

<b>Notice of References Cited</b>	Application/Control No. 10/781,788	Applicant(s)/Patent Under Reexamination YOSHIKAWA, TAKEFUMI	
	Examiner Linh V. Nguyen	Art Unit 2819	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,370,162	04-2002	Takahashi et al.	370/517
*	B	US-6,476,738	11-2002	Mitsutani, Naoki	341/100
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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